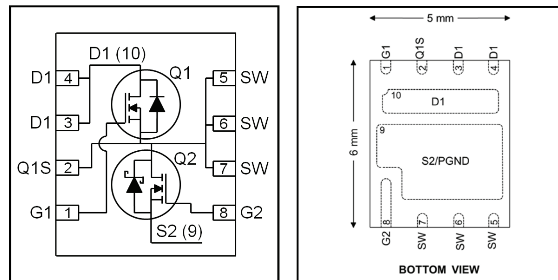
International
IOR Rectifier

FastIRFET™
IRFH4251DPbF

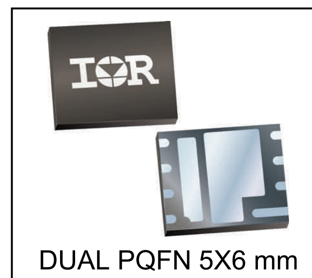
HEXFET® Power MOSFET

	Q1	Q2	
V_{DSS}	25	25	V
$R_{DS(on)}$ max (@V_{GS} = 4.5V)	4.60	1.10	mΩ
Qg (typical)	10	44	nC
I_D (@T_C = 25°C)	45⑦	45⑦	A



Applications

- Control and Synchronous MOSFETs for synchronous buck converters



DUAL PQFN 5X6 mm

Features		Benefits
Control and synchronous MOSFETs in one package		Increased power density
Low charge control MOSFET (10nC typical)		Lower switching losses
Low R_{DSON} synchronous MOSFET (<1.10mΩ)	results in	Lower conduction losses
Intrinsic Schottky Diode with Low Forward Voltage on Q2	⇒	Lower Switching Losses
RoHS Compliant, Halogen-Free		Environmentally friendlier
MSL1, Industrial Qualification		Increased reliability

Base part number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRFH4251DPbF	Dual PQFN 5mm x 6mm	Tape and Reel	4000	IRFH4251DTRPbF

Absolute Maximum Ratings

	Parameter	Q1 Max.	Q2 Max.	Units
V_{GS}	Gate-to-Source Voltage	± 20		V
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ 4.5V	64⑥⑦	188⑥⑦	A
I_D @ T_C = 70°C	Continuous Drain Current, V_{GS} @ 4.5V	51⑥⑦	151⑥⑦	
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ 4.5V (Source Bonding Technology Limited)	45⑦	45⑦	
I_{DM}	Pulsed Drain Current	120	750⑧	
P_D @T_C = 25°C	Power Dissipation	31	63	W
P_D @T_C = 70°C	Power Dissipation	20	40	
	Linear Derating Factor	0.25	0.50	W/°C
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to + 150		°C

Thermal Resistance

	Parameter	Q1 Max.	Q2 Max.	Units
$R_{\theta JC}$ (Bottom)	Junction-to-Case ④	4.0	2.0	°C/W
$R_{\theta JC}$ (Top)	Junction-to-Case ④	20	12	
$R_{\theta JA}$	Junction-to-Ambient ⑤	34	35	
$R_{\theta JA}$ (<10s)	Junction-to-Ambient ⑤	24	22	

Notes ① through ⑧ are on page 12

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Static @ T_J = 25°C (unless otherwise specified)

	Parameter		Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	Q1	25	——	——	V	V_{GS} = 0V, I_D = 250μA
		Q2	25	——	——		V_{GS} = 0V, I_D = 1.0mA
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	Q1	——	22	——	mV/°C	Reference to 25°C, I_D = 1.0mA
		Q2	——	20	——		Reference to 25°C, I_D = 10mA
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	Q1	——	2.50	3.20	mΩ	V_{GS} = 10V, I_D = 30A ③
		Q2	——	0.60	0.85		V_{GS} = 10V, I_D = 30A ③
		Q1	——	3.70	4.60		V_{GS} = 4.5V, I_D = 30A ③
		Q2	——	0.85	1.10		V_{GS} = 4.5V, I_D = 30A ③
$V_{GS(th)}$	Gate Threshold Voltage	Q1	1.1	1.6	2.1	V	Q1: V_{DS} = V_{GS}, I_D = 35μA
		Q2	1.1	1.6	2.1		Q2: V_{DS} = V_{GS}, I_D = 150μA
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient	Q1	——	-5.7	——	mV/°C	Q1: V_{DS} = V_{GS}, I_D = 35μA
		Q2	——	-10	——		Q2: V_{DS} = V_{GS}, I_D = 150μA
I_{DSS}	Drain-to-Source Leakage Current	Q1	——	——	1.0	μA	V_{DS} = 20V, V_{GS} = 0V
		Q2	——	——	250		V_{DS} = 20V, V_{GS} = 0V
I_{GSS}	Gate-to-Source Forward Leakage	Q1/Q2	——	——	100	nA	V_{GS} = 20V
	Gate-to-Source Reverse Leakage	Q1/Q2	——	——	-100		V_{GS} = -20V
gfs	Forward Transconductance	Q1	131	——	——	S	V_{DS} = 10V, I_D = 30A
		Q2	161	——	——		V_{DS} = 10V, I_D = 30A
Q_g	Total Gate Charge	Q1	——	10	15	nC	
		Q2	——	44	66		
Q_{gs1}	Pre-Vth Gate-to-Source Charge	Q1	——	2.5	——		Q1
		Q2	——	11	——		V_{DS} = 13V
Q_{gs2}	Post-Vth Gate-to-Source Charge	Q1	——	1.6	——		V_{GS} = 4.5V, I_D = 30A
		Q2	——	4.2	——		
Q_{gd}	Gate-to-Drain Charge	Q1	——	3.8	——		Q2
		Q2	——	15	——		V_{DS} = 13V
Q_{godr}	Gate Charge Overdrive	Q1	——	2.1	——		V_{GS} = 4.5V, I_D = 30A
		Q2	——	13.8	——		
Q_{sw}	Switch Charge (Q_{gs2} + Q_{gd})	Q1	——	5.4	——		
		Q2	——	19.2	——		
Q_{oss}	Output Charge	Q1	——	10	——	nC	V_{DS} = 16V, V_{GS} = 0V
		Q2	——	44	——		
R_G	Gate Resistance	Q1	——	2.4	——	Ω	
		Q2	——	0.85	——		
$t_{d(on)}$	Turn-On Delay Time	Q1	——	10	——	ns	Q1
		Q2	——	24	——		V_{DS} = 13V V_{GS} = 4.5V
t_r	Rise Time	Q1	——	61	——		I_D = 30A, Rg = 1.8Ω
		Q2	——	105	——		
$t_{d(off)}$	Turn-Off Delay Time	Q1	——	13	——		Q2
		Q2	——	35	——		V_{DS} = 13V V_{GS} = 4.5V
t_f	Fall Time	Q1	——	15	——		I_D = 30A, Rg = 1.8Ω
		Q2	——	60	——		
C_{iss}	Input Capacitance	Q1	——	1314	——	pF	
		Q2	——	5845	——		V_{GS} = 0V
C_{oss}	Output Capacitance	Q1	——	365	——		V_{DS} = 13V
		Q2	——	1703	——		f = 1.0MHz
C_{rss}	Reverse Transfer Capacitance	Q1	——	92	——		
		Q2	——	408	——		

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Avalanche Characteristics

	Parameter	Typ.	Q1 Max.	Q2 Max.	Units
E_{AS}	Single Pulse Avalanche Energy ②	——	61	1292	mJ
I_{AR}	Avalanche Current ①	——	30	60	A

Diode Characteristics

	Parameter		Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	Q1	——	——	45⑦	A	MOSFET symbol showing the integral reverse p-n junction diode.
		Q2	——	——	45⑦		
I_{SM}	Pulsed Source Current (Body Diode)	Q1	——	——	120	A	
		Q2	——	——	750⑧		
V_{SD}	Diode Forward Voltage	Q1	——	——	1.0	V	T_J = 25°C, I_S = 30A, V_{GS} = 0V③
		Q2	——	——	0.75		T_J = 25°C, I_S = 30A, V_{GS} = 0V③
t_{rr}	Reverse Recovery Time	Q1	——	16	——	ns	Q1 T_J = 25°C, I_F = 30A
		Q2	——	36	——		V_{DD} = 13V, di/dt = 235A/μs ③
Q_{rr}	Reverse Recovery Charge	Q1	——	13	——	nC	Q2 T_J = 25°C, I_F = 30A
		Q2	——	67	——		V_{DD} = 13V, di/dt = 190A/μs ③

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Q1 - Control FET

Q2 - Synchronous FET

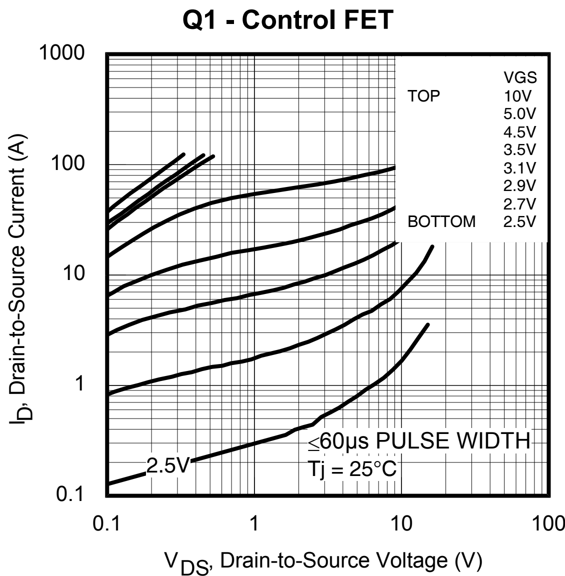

Fig 1. Typical Output Characteristics

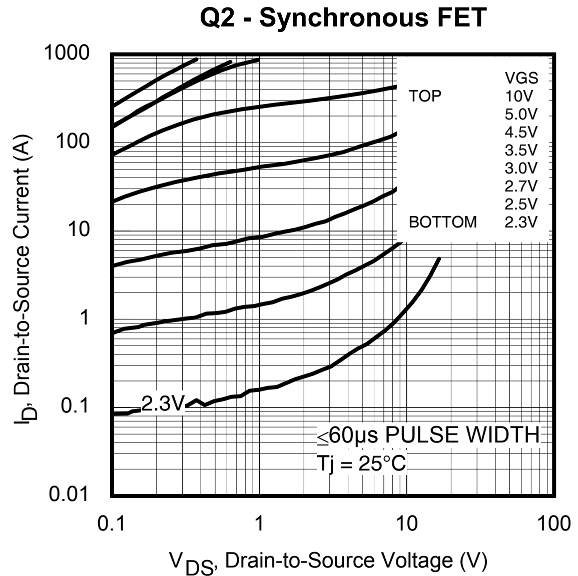

Fig 2. Typical Output Characteristics

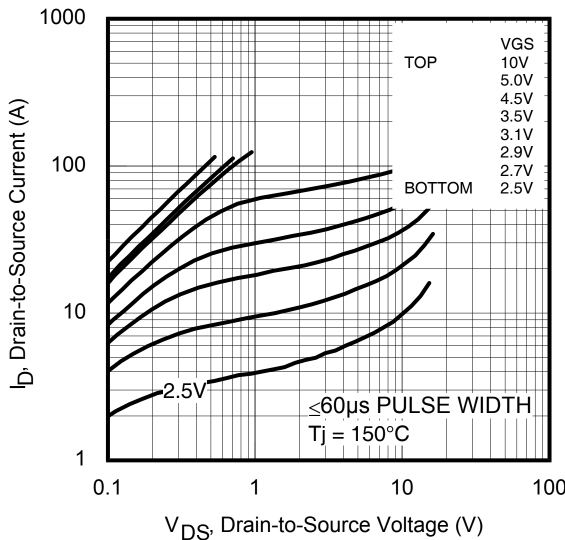

Fig 3. Typical Output Characteristics

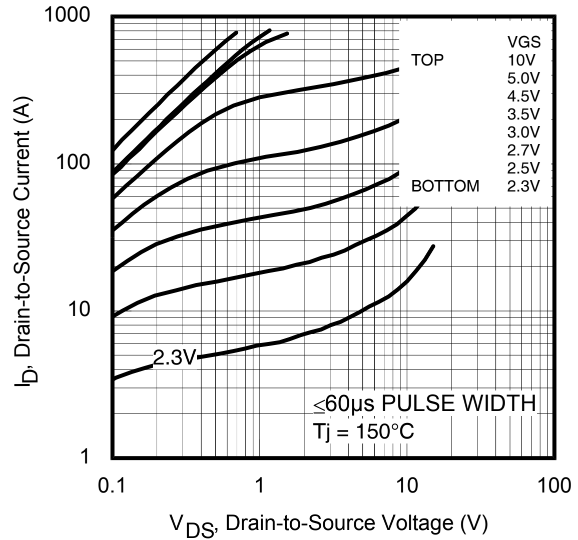

Fig 4. Typical Output Characteristics

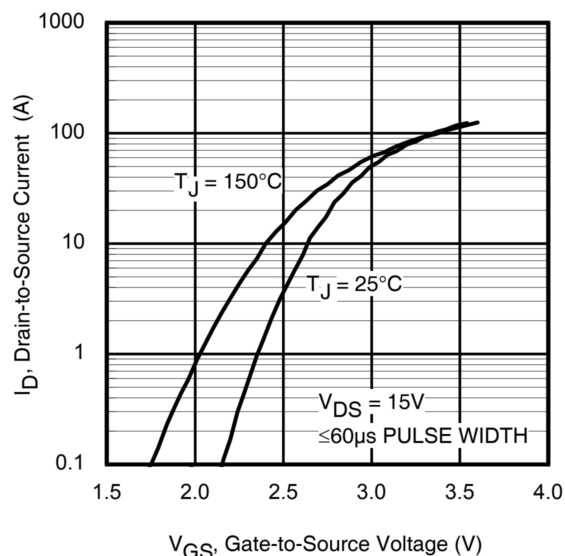

Fig 5. Typical Transfer Characteristics

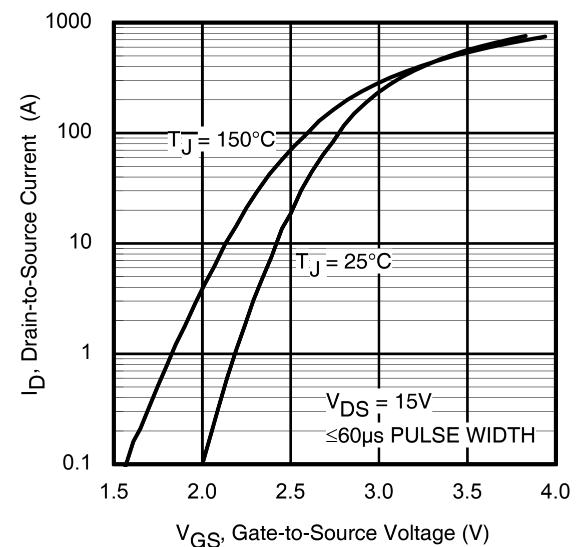

Fig 6. Typical Transfer Characteristics

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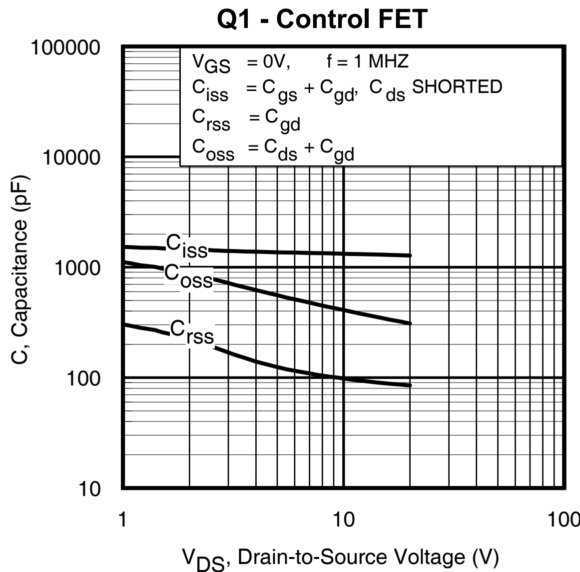

Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

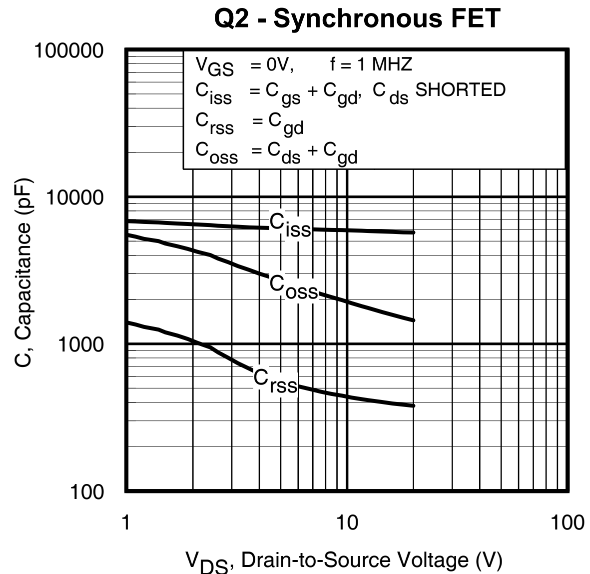

Fig 8. Typical Capacitance vs. Drain-to-Source Voltage

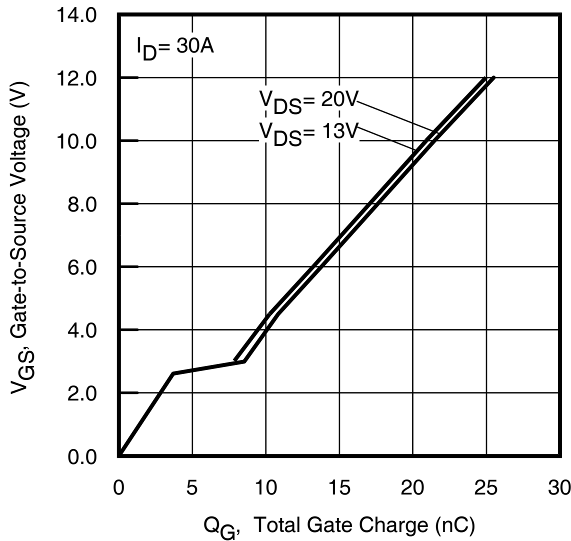

Fig 9. Typical Gate Charge vs. Gate-to-Source Voltage

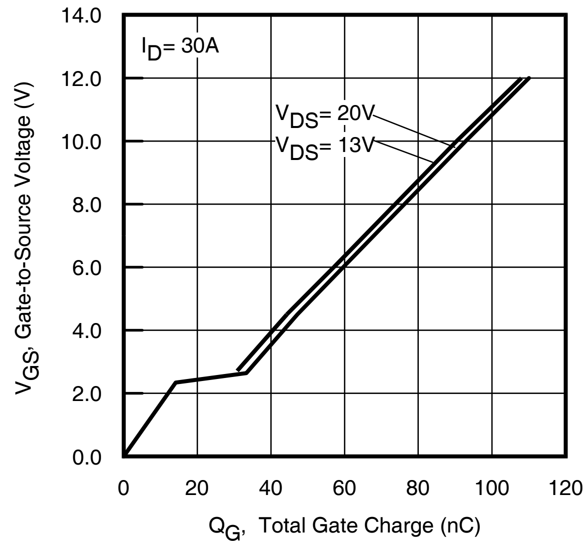

Fig 10. Typical Gate Charge vs. Gate-to-Source Voltage

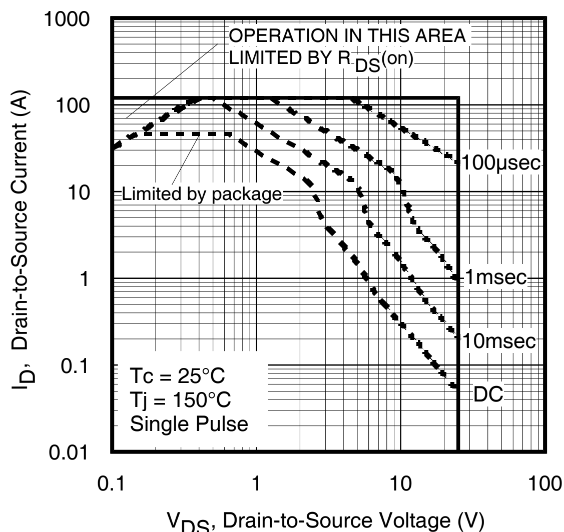

Fig 11. Maximum Safe Operating Area

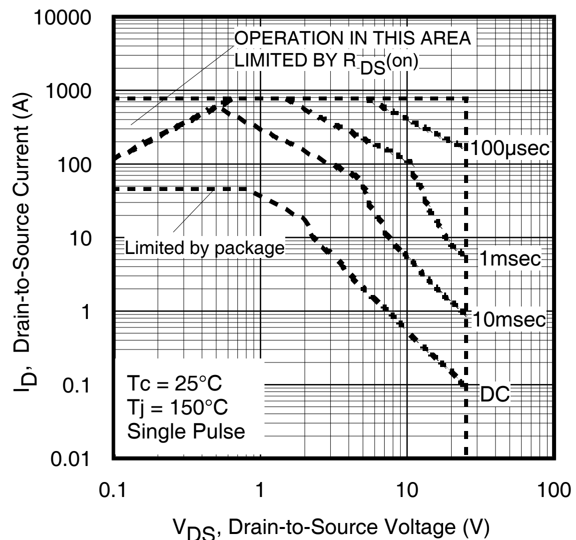

Fig 12. Maximum Safe Operating Area

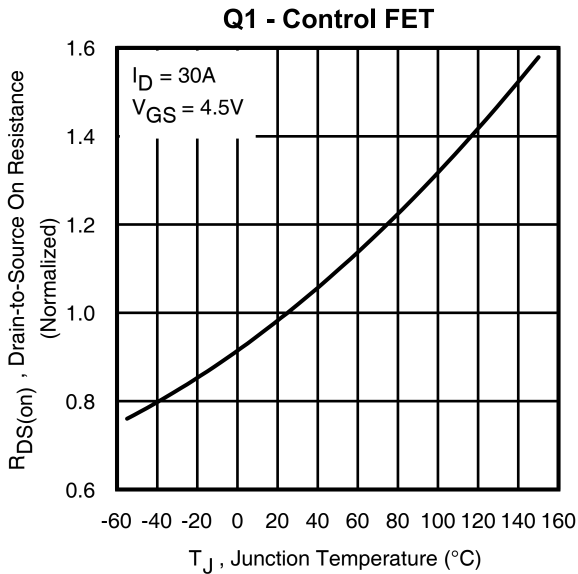

Fig 13. Normalized On-Resistance vs. Temperature

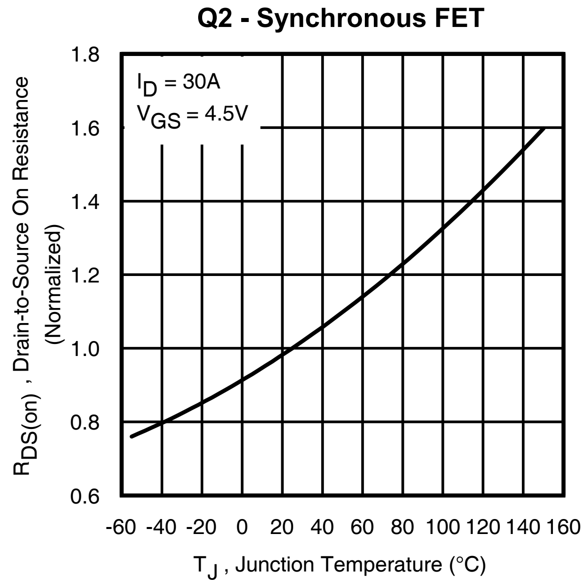

Fig 14. Normalized On-Resistance vs. Temperature

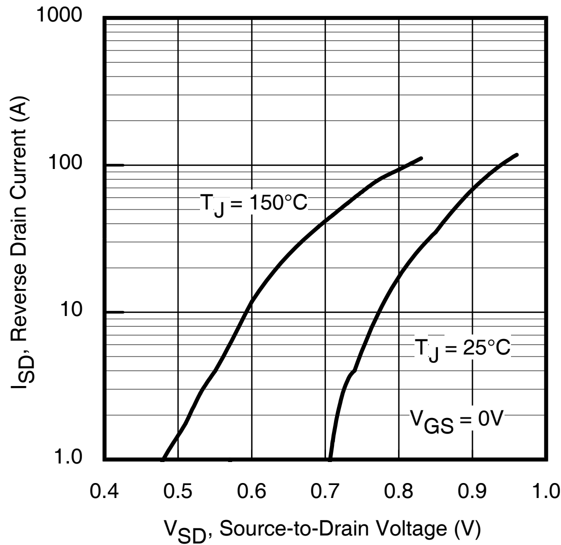

Fig 15. Typical Source-Drain Diode Forward Voltage

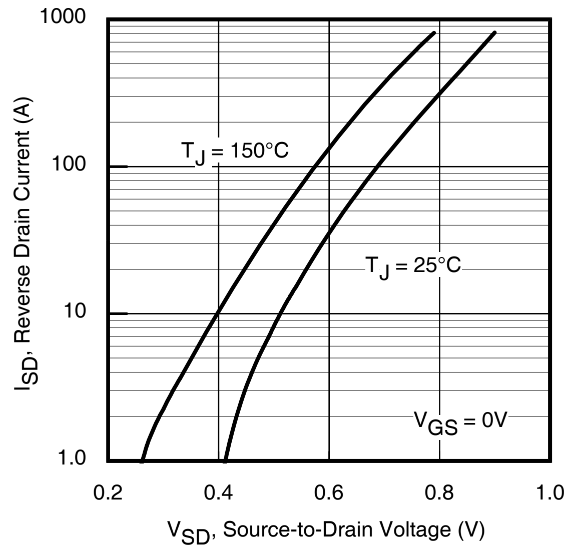

Fig 16. Typical Source-Drain Diode Forward Voltage

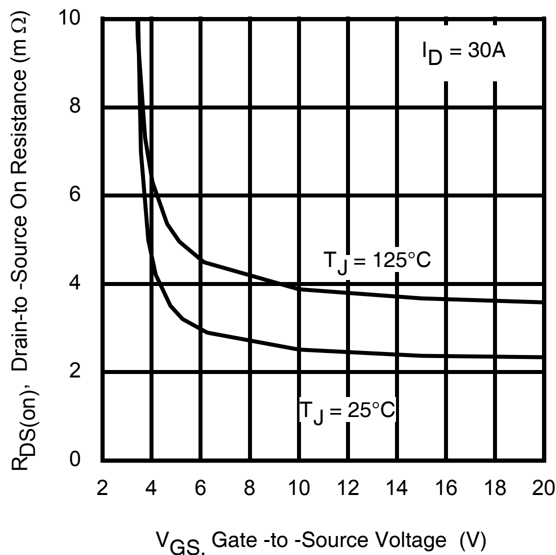

Fig 17. Typical On-Resistance vs. Gate Voltage

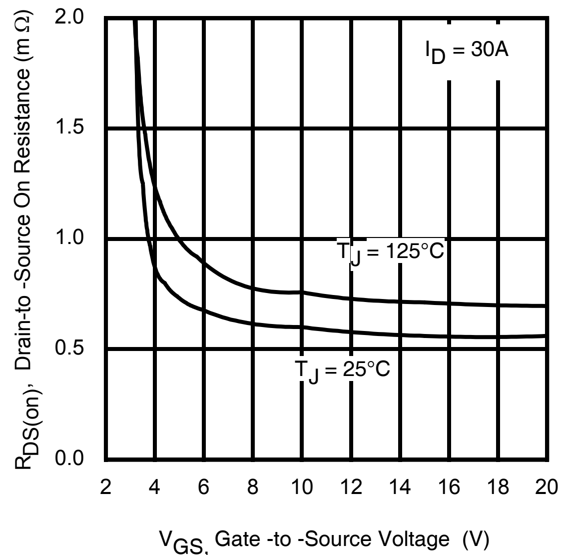

Fig 18. Typical On-Resistance vs. Gate Voltage

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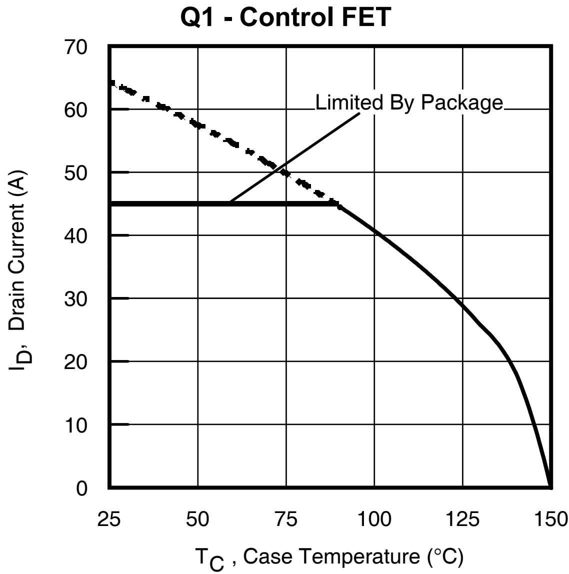

Fig 19. Maximum Drain Current vs. Case Temperature

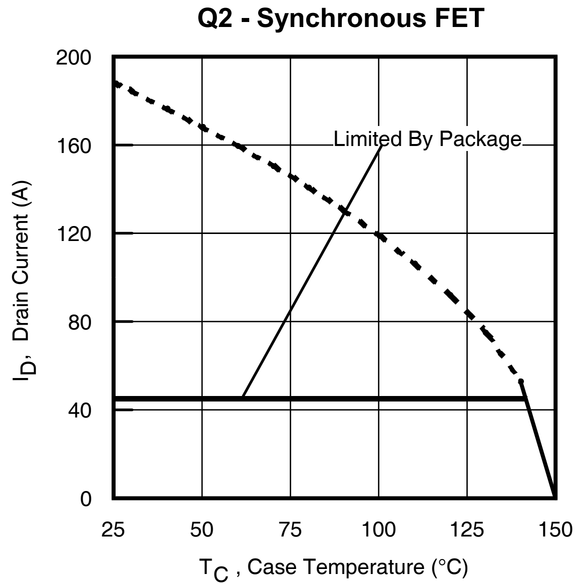

Fig 20. Maximum Drain Current vs. Case Temperature

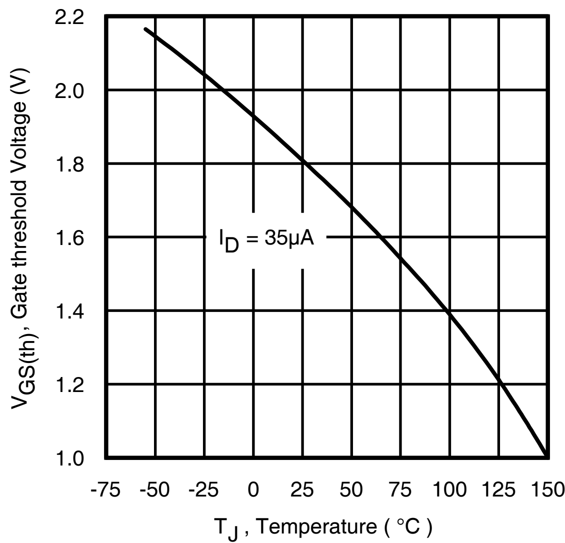

Fig 21. Threshold Voltage vs. Temperature

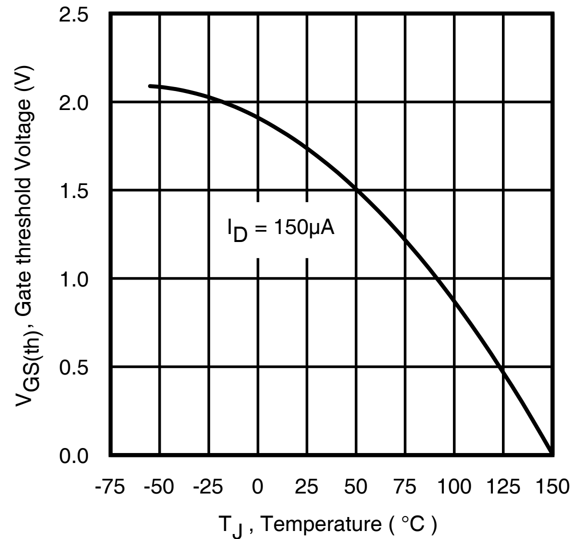

Fig 22. Threshold Voltage vs. Temperature

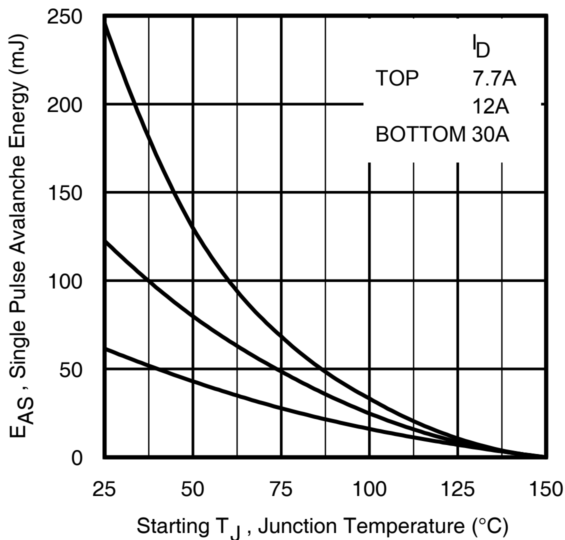

Fig 23. Maximum Avalanche Energy vs. Drain Current

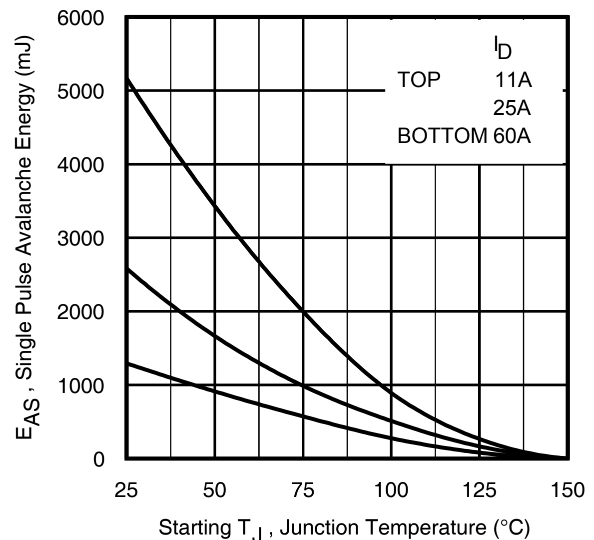

Fig 24. Maximum Avalanche Energy vs. Drain Current

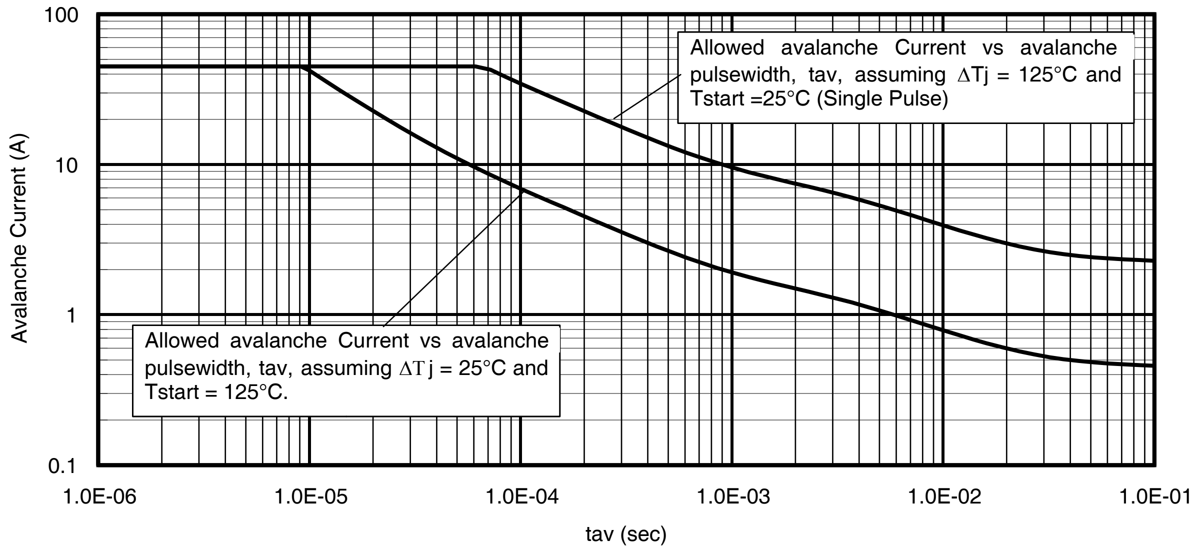

Fig 25. Max Avalanche Current vs. Pulse Width (Q1)

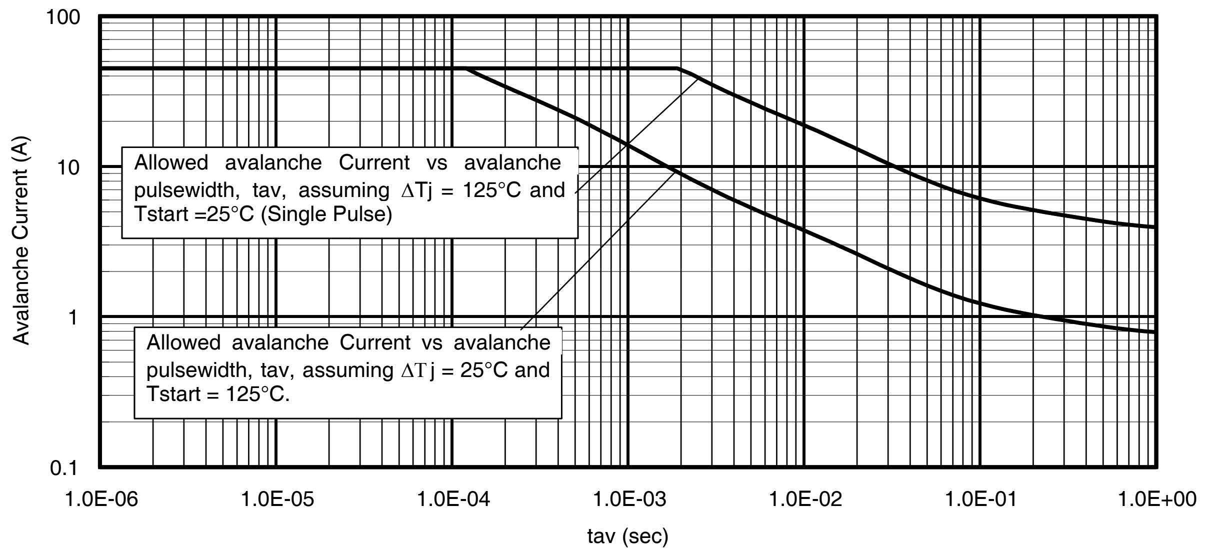

Fig 26. Max Avalanche Current vs. Pulse Width (Q2)

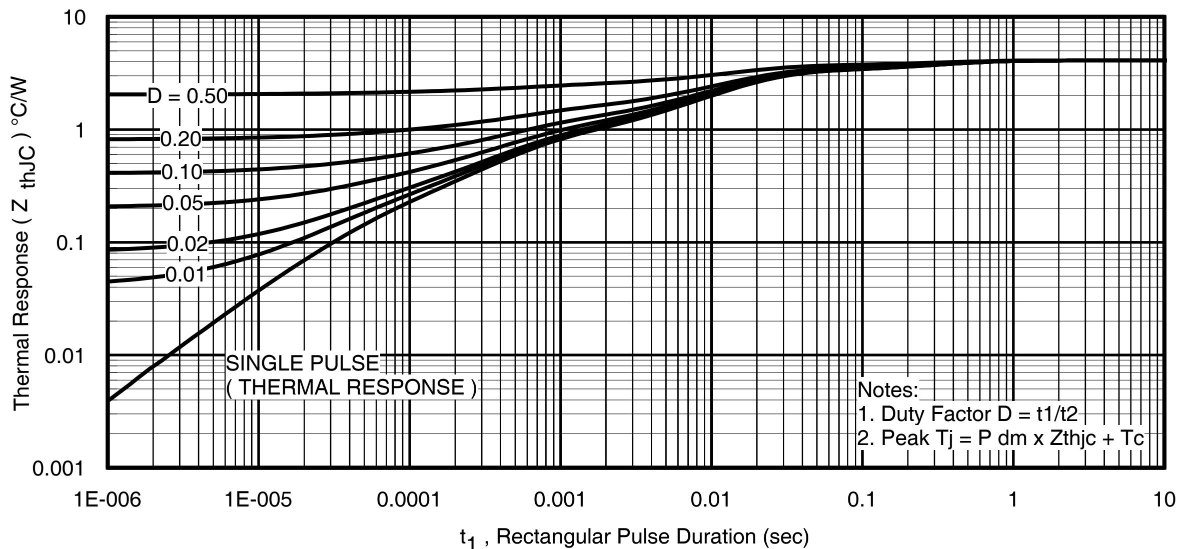

Fig 27. Maximum Effective Transient Thermal Impedance, Junction-to-Case (Q1)

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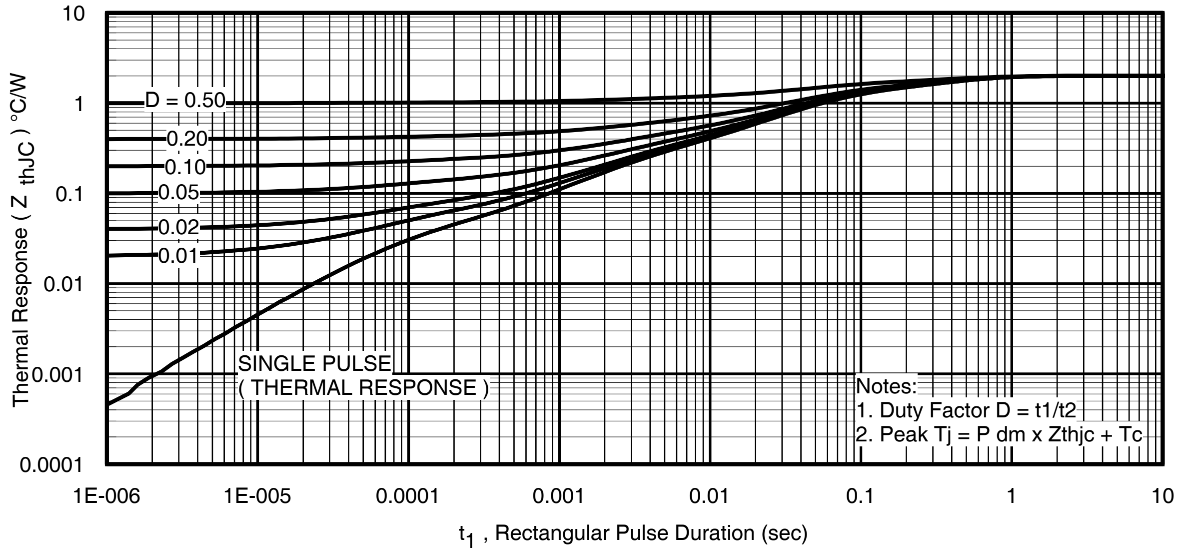

Fig 28. Maximum Effective Transient Thermal Impedance, Junction-to-Case (Q2)

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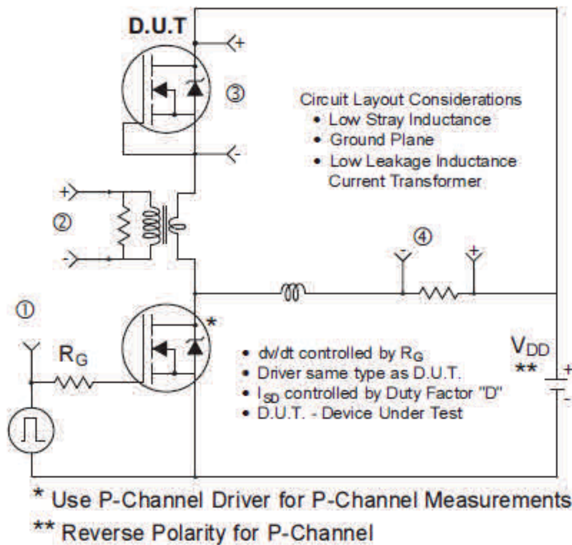

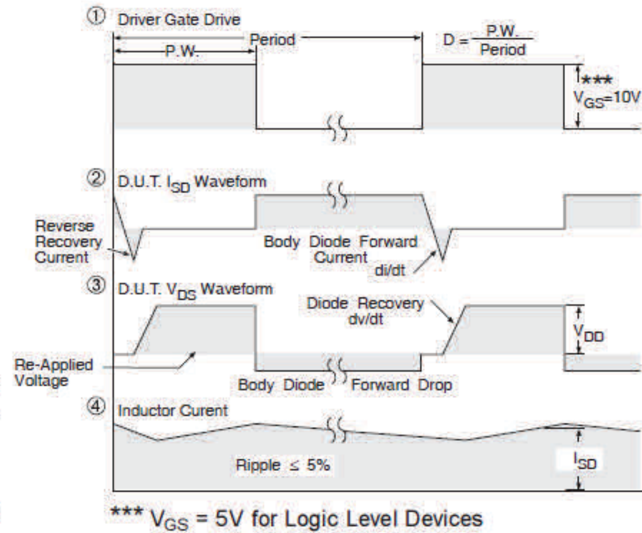

Fig 29. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

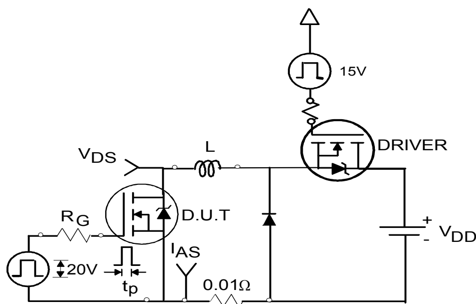

Fig 30a. Unclamped Inductive Test Circuit

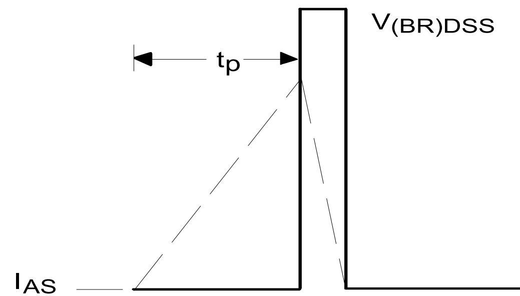

Fig 30b. Unclamped Inductive Waveforms

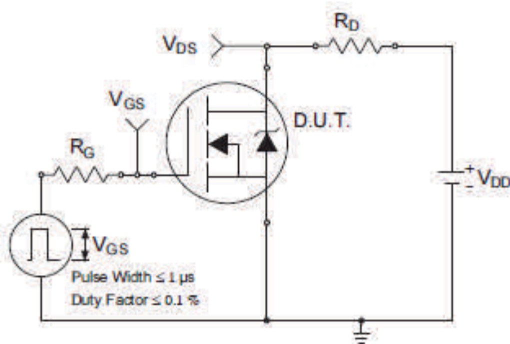

Fig 31a. Switching Time Test Circuit

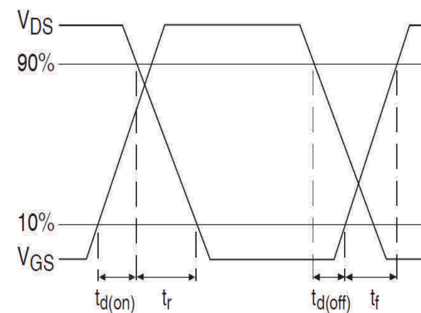

Fig 31b. Switching Time Waveforms

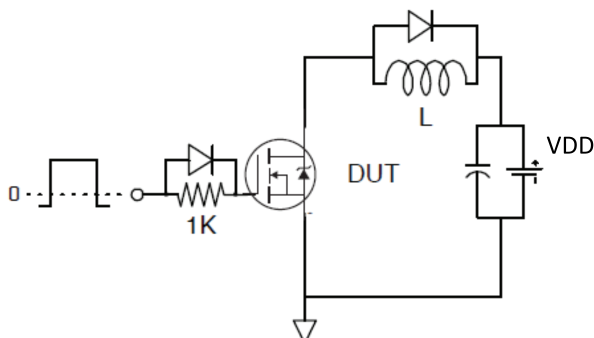

Fig 32a. Gate Charge Test Circuit

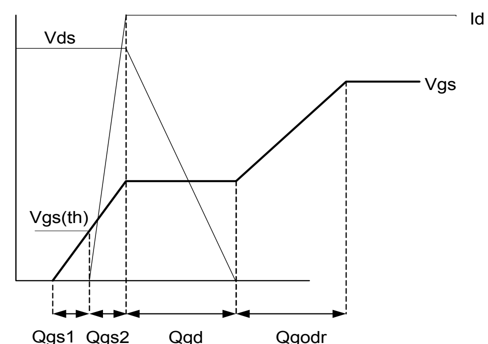

Fig 32b. Gate Charge Waveform

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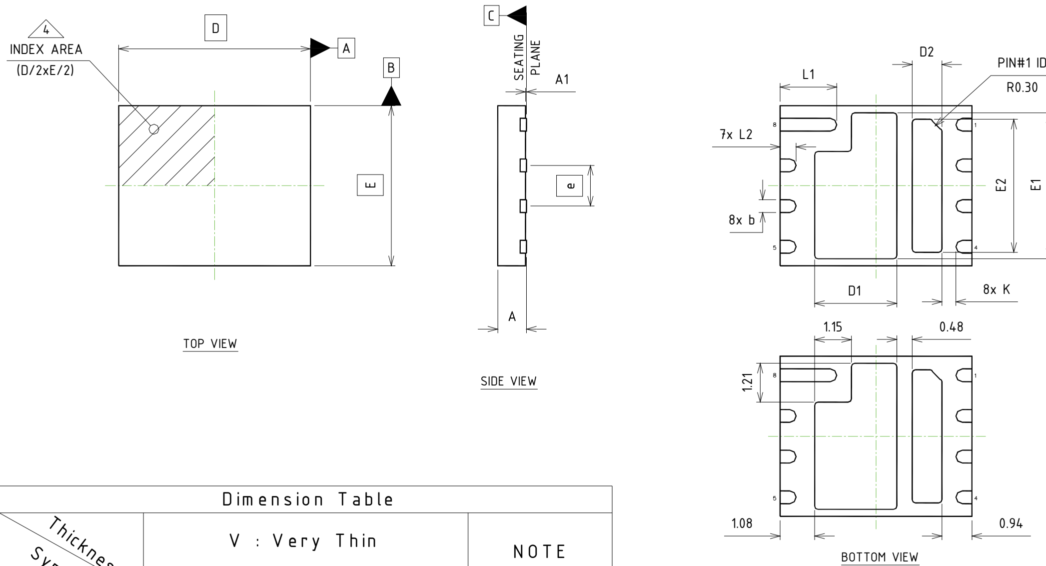
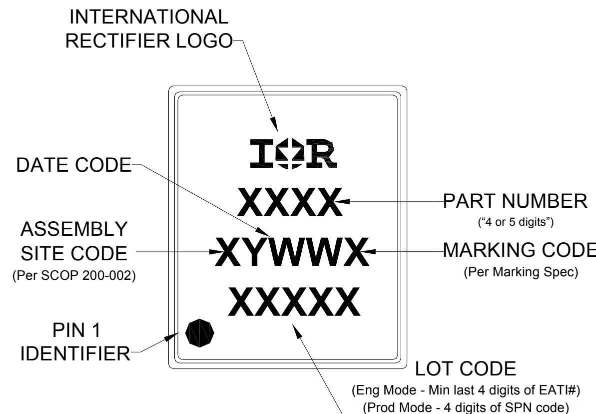
Dual PQFN 5x6 Outline "H" Package Details



Symbol \ Thickness	V : Very Thin			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
A	0.80	0.90	1.00	
A1	0.00	0.02	0.05	
b	0.30	0.40	0.50	6
D		6.00 BSC		
E		5.00 BSC		
e		1.27 BSC		
D1	2.42	2.57	2.67	
E1	4.41	4.56	4.66	
D2	0.78	0.93	1.03	
E2	4.01	4.16	4.26	
K	0.20	---	---	
L1	1.67	1.77	1.87	
L2	0.40	0.50	0.60	

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: http://www.irf.com/technical-info/appnotes/an-1136.pdf
For more information on package inspection techniques, please refer to application note AN-1154: http://www.irf.com/technical-info/appnotes/an-1154.pdf

PQFN 5x6 Outline "H" Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

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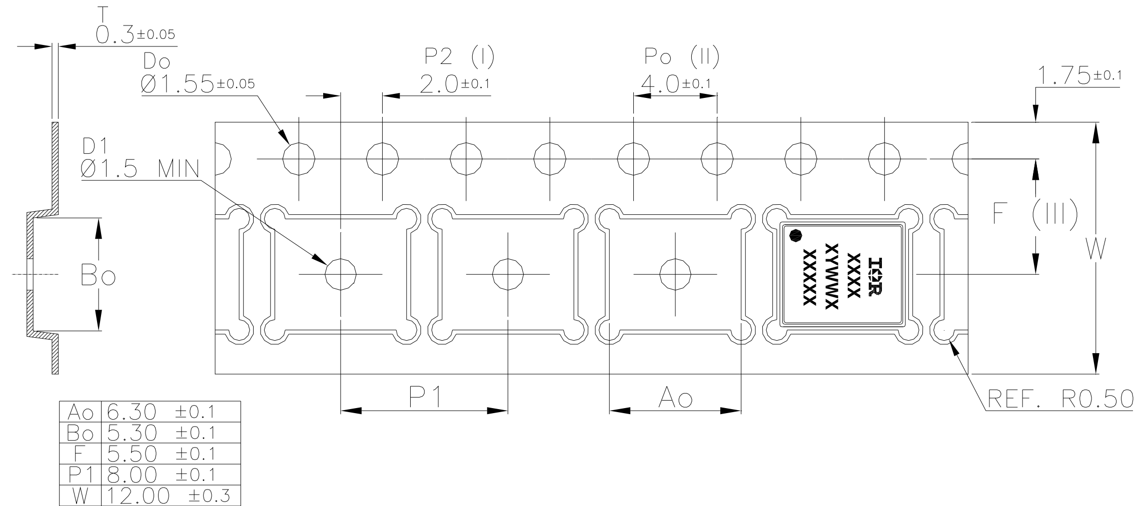
Dual PQFN 5x6 Outline Tape and Reel



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Qualification Information†

Qualification level	Industrial (per JEDEC JESD47F †† guidelines)	
Moisture Sensitivity Level	DUAL PQFN 5mm x 6mm	MSL1 (per JEDEC J-STD-020D††)
RoHS Compliant	Yes	

† Qualification standards can be found at International Rectifier's web site http://www.irf.com/product-info/reliability

†† Applicable version of JEDEC standard at the time of product release.

Notes:

① Repetitive rating; pulse width limited by max. junction temperature.

② Starting T_J = 25°C,
Q1: L = 0.14mH, R_G = 50Ω, I_{AS} = 30A;
Q2: L = 0.72mH, R_G = 50Ω, I_{AS} = 60A.

③ Pulse width ≤ 400μs; duty cycle ≤ 2%.

④ R_θ is measured at T_J approximately 90°C.

⑤ When mounted on 1 inch square PCB (FR-4). Please refer to AN-994 for more details: http://www.irf.com/technical-info/appnotes/an-994.pdf

⑥ Calculated continuous current based on maximum allowable junction temperature.

⑦ Current is limited to Q1 = 45A & Q2 = 45A by source bonding technology.

⑧ Pulsed drain current is limited to 180A by source bonding technology.

Revision History

Date	Comments
05/28/2013	• Updated the schematic drawing, on page 1. • Updated the Features and Benefits table, on page 1. • Updated Vsd for Q2 from 1.0V to 0.75V, on page 3. • Added Tape and Reel drawing, on page 12.
06/10/2013	• Updated the MSL level from MSL3 to MSL2, on pages 1 & 12.
08/15/2013	• Added “Fast*I*RFET™” above the part number, on page 1. • Added part marking drawing, on page 11.
01/16/2014	• Update the MSL level from MSL2 to MSL1, on page 1 & 12.
5/20/2014	• Updated fig. 25 to show the max avalanche plateau at 45A, on page 8. • Corrected fig. 26 to cap the curves at package limitation current of 45A, on page 8.

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